Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/564,416	ANDO ET AL.
Examiner	Art Unit

Sara W. Crane

	SEAR	CHED	
Class	Subclass	Date	Examiner
257	103	6/06	SWC

INT	TERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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